

Serie n°3 – September 24th

Complex Numbers
Reciprocal spaces, X-ray diffraction

Exercise 1 :

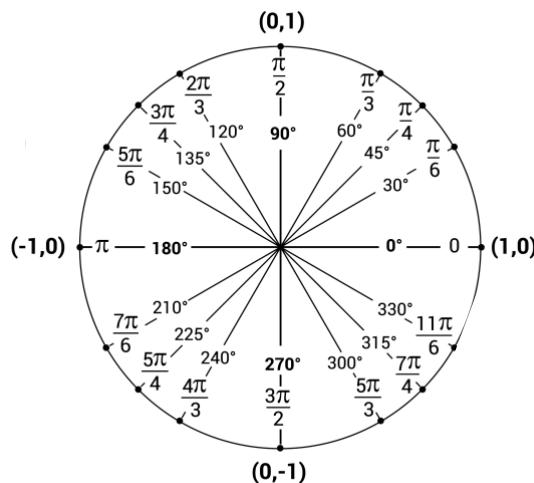
- What are the real and imaginary parts of: (i) $\sqrt{-16}$; (ii) $\frac{1+3i}{2+i}$
- Find the modulus and argument of the following complex numbers, and express in the polar form: (i) $\frac{1}{\sqrt{2}}(1+i)$; (ii) $\frac{1+i\sqrt{3}}{1+i}$
- Simplify the following complex expressions: $\left(\frac{1+i}{1-i}\right)^{2024}$
- Using Euler's relation, show that:
 $\forall (x, y) \in \mathbb{R}^2, \sin(x + iy) = \sin(x) \operatorname{ch}(y) + i \cos(x) \operatorname{sh}(y)$
(Reminder: $\forall y \in \mathbb{R}, \operatorname{ch}(y) = \frac{e^y + e^{-y}}{2}$ and $\operatorname{sh}(y) = \frac{e^y - e^{-y}}{2}$)
- Use this expression to find one solution of the equation in \mathbb{C} : $\sin(z) = 2$.

Exercise 2 : Trigonometry and unit circle

- Place with a cross the following complex numbers on the unit circle below:

(i) $e^{i\frac{7\pi}{4}}$; (ii) $\frac{1}{\sqrt{2}}(1-i)$; (iii) $z = i \times \frac{\sqrt{3}+i}{2}$;

- Calculate the roots of the equation: $z^3 = \cos\left(\frac{3\pi}{2}\right) + i \sin\left(\frac{3\pi}{2}\right)$. Place them on the unit circle and show that they form an equilateral triangle.



Exercise 3: Complex index of refraction and absorption coefficient

We consider a dielectric material inside which a monochromatic plane wave with a frequency in the Infrared is traveling. The frequency turns out to correspond to a vibrational mode of the crystal lattice, leading to a transfer of energy between the electromagnetic wave and the medium. The wave is hence losing energy as it is traveling, which we can approach by considering a complex dielectric constant and index of refraction. We then define:

$$\varepsilon_r = \varepsilon_1 + i\varepsilon_2 \text{ and } n = n_1 + in_2$$

Where ε_1 and ε_2 are the real and imaginary parts of the dielectric constant respectively and n_1 and n_2 are the real and imaginary parts of the index of refraction, respectively. We remind you that $n = \sqrt{\varepsilon_r}$

3a. Show that we must have:
$$\begin{cases} n_1^2 - n_2^2 = \varepsilon_1 \\ 2n_1n_2 = \varepsilon_2 \end{cases}$$

3b. Deduce that:
$$\begin{cases} n_1 = \frac{1}{\sqrt{2}} \sqrt{(\varepsilon_1 + \sqrt{\varepsilon_1^2 + \varepsilon_2^2})} \\ n_2 = \frac{1}{\sqrt{2}} \sqrt{(-\varepsilon_1 + \sqrt{\varepsilon_1^2 + \varepsilon_2^2})} \end{cases}$$

3c. We consider a plane wave of angular frequency ω and vector $k = \frac{2\pi}{\lambda}n$, λ being the wavelength, traveling along the x axis: $\vec{E}(x, t) = \vec{E}_0 e^{i(kx - \omega t)}$.

Knowing that the intensity at a point x in the material is $I(x) = |\vec{E}(x, t)|^2$, show that :

$$I = I(0)e^{-\alpha x} \text{ with } \alpha = \frac{4\pi}{\lambda}n_2$$

3d. Absorption and attenuation

(i) Gallium Arsenide (GaAs) is a material widely used in optoelectronics and particularly in photovoltaics, in part because of its high absorption in the visible. At $600 \text{ nm} = 6 \times 10^{-7} \text{ m}$, $n_2 = 0.6$.

What is the penetration depth δ_{GaAs} at 600 nm, that is the length of propagation inside the material for which $\frac{I(\delta)}{I(0)} = \frac{1}{e}$?

(ii) Light in an silica optical fiber propagates in the core with a very low attenuation of the glass at the telecommunication wavelength $\lambda = 1.55 \mu\text{m}$. Typically, amplifiers are put every 50 km of fiber to reinforce the signal. This corresponds to a loss of 90% of intensity of the signal: $\frac{I(50 \text{ km})}{I(0)} = 0.1$

Calculate what is the imaginary index of refraction of silica at $\lambda = 1.55 \mu\text{m}$?

Exercise 4 : Rheology and complex numbers

Dynamic or oscillatory rheology is a powerful technique to characterize the viscoelastic properties of materials (e.g. its viscosity η). A schematic is illustrated on the right picture: a cylindrical sample is placed between two parallel plates and a sinusoidal deformation (stress or strain) is applied to the material through the oscillation of the top plate at a fixed frequency ω . The material response (strain or stress) is then measured.

Let's assume that a sinusoidal strain γ^* is applied and that the stress τ^* is measured, both of them can be expressed using the complex exponential function: $\gamma^* = \gamma_0 e^{i\omega t}$, $\tau^* = \tau_0 e^{i(\omega t + \delta)}$.

With δ the phase shift between the deformation and the response ($\delta = 0$ for a purely elastic material, $\delta = \frac{\pi}{2}$ for a purely viscous one, and $0 < \delta < \frac{\pi}{2}$ for viscoelastic materials).

4a. In the linear regime, recall that the following relation links γ^* and τ^* : $\tau^* = G^* \gamma^*$ where $G^* = G' + iG''$ is the complex modulus. Show that:

$$G' = \frac{\tau_0}{\gamma_0} \cos(\delta) \text{ and } G'' = \frac{\tau_0}{\gamma_0} \sin(\delta)$$

4b. G' and G'' are respectively the storage and loss modulus.

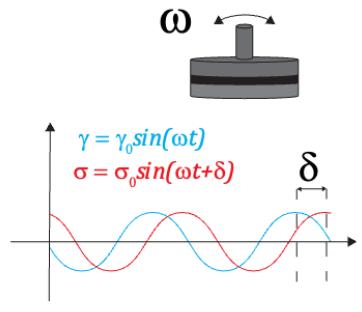
- (i) In order to measure the material damping properties, the value of $\tan(\delta)$ can be computed. Show that $\tan(\delta) = \frac{G''}{G'}$.
- (ii) What value of $\tan(\delta)$ would you expect for a purely elastic material ? and a purely viscous material ? If you consider now a viscoelastic material, what can you conclude on the meaning of G' and G'' ?

4c. Express the value of the complex viscosity extracted from oscillatory rheology as a function of G' and G'' and conclude that it can be written as $\eta^* = \eta' + i\eta''$.

(Recall: $\tau = \eta \times \dot{\gamma} = \eta \times \frac{d\gamma}{dt}$).

4d. Show that $|\eta^*| = \frac{|G^*|}{\omega}$

4e. Now assume that you are applying a sinusoidal stress $\tau^* = \tau_0 e^{i\omega t}$ and you measure the response strain $\gamma^* = \gamma_0 e^{i(\omega t + \delta)}$. Compute once again the complex modulus G^* and the complex viscosity η^* and show that we still have $|\eta^*| = \frac{|G^*|}{\omega}$.



$$G' = (\sigma_0 / \gamma_0) \cos(\delta) \leftrightarrow \text{Elasticity}$$

$$G'' = (\sigma_0 / \gamma_0) \sin(\delta) \leftrightarrow \text{Viscous Nature}$$